Application/Control No. Applicant(s)/Patent Under Reexamination 10/664,904 TANAKA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 3753 Leonard R. Leo

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
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	J	US-			
	К	US-			
	L	US-			
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FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
X	Ν	JP 59028847 A	02-1984	Japan	KOKUBU	
X	0	JP 62018056 A	01-1987	Japan	ITAHANA et al.	
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NON-PATENT DOCUMENTS

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